



United States Patent and Trademark Office

UNITED STATES DEPARTMENT OF COMMERCE United States Patent and Trademark Office Address: COMMISSIONER OF PATENTS AND TRADEMARKS Washington, D.C. 20231 www.uspio.gov

APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
APPLICATION NO.	FICING DATE	TRST NAMED IN ENTOR	ATTORIVET BOCKET NO:	CONTINUATION NO.
09/628,310	07/28/2000	KENJI NISHI	106827	3797
25944 75	90 03/03/2003			
OLIFF & BERRIDGE, PLC			EXAMINER	
P.O. BOX 19928			ESPLIN, DAVID B	
ALEXANDRIA	A, VA 22320			
			ART UNIT	PAPER NUMBER
			2851	
			DATE MAILED: 03/03/2003	

Please find below and/or attached an Office communication concerning this application or proceeding.

		Application No.	Applicant(s)			
		09/628,310	NISHI, KENJI			
,	Office Acti n Summary	Examiner	Art Unit			
		D. Ben Esplin	2851			
Period fo	The MAILING DATE of this communication appears on the cover sheet with the correspondence address Period for Reply					
THE I - Exter after - If the - If NO - Failui - Any r earne Status	ORTENED STATUTORY PERIOD FOR REPLY MAILING DATE OF THIS COMMUNICATION. In scions of time may be available under the provisions of 37 CFR 1.13 SIX (6) MONTHS from the mailing date of this communication. Period for reply specified above is less than thirty (30) days, a reply period for reply is specified above, the maximum statutory period we re to reply within the set or extended period for reply will, by statute, eply received by the Office later than three months after the mailing and patent term adjustment. See 37 CFR 1.704(b).	36(a). In no event, however, may a reply be time within the statutory minimum of thirty (30) days will apply and will expire SIX (6) MONTHS from cause the application to become ABANDONE date of this communication, even if timely filed	nely filed s will be considered timely. the mailing date of this communication.			
1)	Responsive to communication(s) filed on					
2a)□	<i>,</i> —	s action is non-final.				
3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213. Disposition of Claims						
4)⊠ Claim(s) <u>1-56</u> is/are pending in the application.						
4a) Of the above claim(s) is/are withdrawn from consideration.						
5) Claim(s) is/are allowed.						
6)⊠	6)⊠ Claim(s) <u>1-5,9-12,15-20,22-29,32-43 and 45-56</u> is/are rejected.					
7)🖂	7)⊠ Claim(s) <u>6-8,13,14,21,30,31 and 44</u> is/are objected to.					
8)	8) Claim(s) are subject to restriction and/or election requirement.					
Application Papers						
9)⊠ The specification is objected to by the Examiner.						
10) ☐ The drawing(s) filed on is/are: a) ☐ accepted or b) ☐ objected to by the Examiner.						
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).						
11) ☐ The proposed drawing correction filed on is: a) ☐ approved b) ☐ disapproved by the Examiner.						
If approved, corrected drawings are required in reply to this Office action.						
12) The oath or declaration is objected to by the Examiner.						
Priority under 35 U.S.C. §§ 119 and 120						
13) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).						
a)[∑	a)⊠ All b)⊡ Some * c)⊡ None of:					
1	1. Certified copies of the priority documents have been received.					
	2. Certified copies of the priority documents have been received in Application No					
 Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received. 						
1	14) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application).					
a) The translation of the foreign language provisional application has been received.						
15) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121.						
Attachment(s)						
2) Notice 3) Inform	of References Cited (PTO-892) of Draftsperson's Patent Drawing Review (PTO-948) ation Disclosure Statement(s) (PTO-1449) Paper No(s) 3, 4	5) Notice of Informal Pa	PTO-413) Paper No(s) atent Application (PTO-152)			
U.S. Patent and Trac PTO-326 (Rev.		on Summary	Part of Paper No. 8			

Information Disclosure Statement

The information disclosure statement filed 9/18/00 fails to comply with 37 CFR 1.98(a)(3) because it does not include a concise explanation of the relevance, as it is presently understood by the individual designated in 37 CFR 1.56(c) most knowledgeable about the content of the information, of each patent listed that is not in the English language. It has been placed in the application file, but the information referred to therein has not been considered.

The information disclosure statement filed 10/20/00 fails to comply with the provisions of 37 CFR 1.97, 1.98 and MPEP § 609 because there is no PTOL-1449 form included with the material. It has been placed in the application file, but the information referred to therein has not been considered as to the merits. Applicant is advised that the date of any re-submission of any item of information contained in this information disclosure statement or the submission of any missing element(s) will be the date of submission for purposes of determining compliance with the requirements based on the time of filing the statement, including all certification requirements for statements under 37 CFR 1.97(e). See MPEP § 609 ¶ C(1).

Drawings

The drawings are objected to under 37 CFR 1.83(a). The drawings must show every feature of the invention specified in the claims. Therefore, any exposure method must be shown in the form of a flowchart, or the method(s) canceled from the claim(s). No new matter should be entered.

Art Unit: 2851

A proposed drawing correction or corrected drawings are required in reply to the Office action to avoid abandonment of the application. The objection to the drawings will not be held in abeyance.

Specification

The lengthy specification has not been checked to the extent necessary to determine the presence of all possible minor errors. Applicant's cooperation is requested in correcting any errors of which applicant may become aware in the specification.

Claim Objections

Claims 6-8 are objected to because of the following informalities: Claim 1, from which these claims depend includes the method step of "measuring a height of the surface of the substrate at a measuring point". But claim 6 discloses that the height of a fiducial member, not the substrate, is measured. These conflicting limitations create an unclear scope of claimed subject matter. Should this objection be overcome, by amendment or argument, the subject matter of measuring the height of a fiducial member at a plurality of positions and storing a result of the measurement for determining inclination of the substrate stage, along with the rest of the structure and function of these claims, is not found in the prior art. Appropriate correction is required.

Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

Application/Control Number: 09/628,310

Art Unit: 2851

A person shall be entitled to a patent unless -

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

Claims 1-5, 9-12, 15-20, 22-29, 32-35, 36-43, and 45-56 are rejected under 35 U.S.C. 102(b) as being anticipated by Japanese Patent Application Laid-Open 6-283403.

FIG. 20 of Japanese application 6-283403 shows an exposure apparatus including a focus position-measuring unit (focal position detection unit including elements 60-71), and a focusing stage (Z leveling stage 54). Japanese application 6-283403 further shows an inclination angle-measuring unit (focal position detection unit as shown in FIG. 21). FIG. 21 represents the location of a plurality of measuring points at which the height of the surface of the substrate arc measured, including a series of points perpendicular to the scan direction, and a series of points parallel to the scan direction. The apparatus of FIG. 20 still further includes a measuring unit (interferometer 57) with a fiducial member (mirror 56) for measuring the X and Y coordinates (or rolling amount) of the stage at all times. FIG. 1 of Japanese application 6-283403 shows an alternative fiducial member (reference mark board 6) for measuring the straightness of the substrate stage.

According to Applicant, Japanese application 6-283403 discloses an exposure method including the steps of measuring a height of the surface of a substrate in front of an exposure area in a relative movement direction (page 3 lines 5-9 of subject application), and setting the positional relationship based on this measurement (page 3 lines 9-13). Since the height and inclination are measured prior to exposure the measuring point would inherently be in front of the exposure area, and would mean that the measurement takes place during scanning of the substrate. Further, since in the method of Japanese application 6-283403 the height and

Art Unit: 2851

inclination (or pitch) of the substrate is continuously being monitored, a plurality of points are created where the height and inclination are measured.

Referring specifically to claims 54-56, these claims are product-by-process claims, meaning that the devices claimed must be materially distinguishable of a device produced by the prior art, and not the processes of their production. Since a device formed using the methods claimed would be indistinguishable from a device formed by Japanese application 6-283403, these claims are also anticipated by Japanese application 6-283403.

Allowable Subject Matter

Claims 13, 14, 21, 30, 31, and 44 are objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims.

The following is an examiner's statement of reasons for allowance:

Referring to claims 13 and 14, an exposure method including the use of a fiducial member that is detachable for use by a plurality of exposure apparatuses, along with the rest of the structure and function of these claims, is not found in the prior art.

In reference to claims 21 and 44, an exposure apparatus including including a detection range of a second focus position-measuring unit that is wider than the detection range of a first focus position-measuring unit, with the rest of the limitations recited in these claims, is not shown in the prior art.

Regarding claims 30 and 31, an exposure apparatus including an inclination angelmeasuring unit that measures a height of a surface of a fiducial member at a plurality of positions Art Unit: 2851

Allowance."

within a movement stroke of the substrate stage, in conjunction with the rest of the elements of

these claims, is not taught in the prior art.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for

Conclusion

The prior art made of record and not relied upon is considered pertinent to applicant's disclosure.

U.S. Patent No. 6,122,036 to Yamasaki et al. discloses a projection exposure apparatus including a fiducial member, an inclination and height detector, and a roll detector.

U.S. Patent No. 5,510,892 to Mizutani et al. discloses an inclination detecting exposure apparatus with a separate height detector.

U.S. Patent No. 5,602,400 to Kawashima discloses an exposure apparatus with a substrate surface detector for detecting the surface of a substrate at a plurality of different locations.

U.S. Patent No. 5,114,234 to Otsuka et al. discloses an exposure apparatus with an inclination and roll detector.

Application/Control Number: 09/628,310

Art Unit: 2851

Any inquiry concerning this communication or earlier communications from the

examiner should be directed to D. Ben Esplin whose telephone number is (703) 305-4022. The

examiner can normally be reached on Mon.-Fri. (8am-4:30 pm).

If attempts to reach the examiner by telephone are unsuccessful, the examiner's

supervisor, Russell E. Adams can be reached on (703) 308-2847. The fax phone numbers for the

organization where this application or proceeding is assigned are (703) 872-9318 for regular

communications and (703) 872-9319 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding

should be directed to the receptionist whose telephone number is (703) 308-0956.

DBE

February 25, 2003

Manual aller RUSSELL ADAMS

SUPERVISORY PATENT EXAMINER

Page 7

TECHNOLOGY CENTER 2800